Search Notes		
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/750,024	CHEN ET AL.
Examiner	Art Unit
James A. Dudek	2871

SEARCHED			
Class	Subclass	Date	Examiner
updated	·	3/14/2006	JAD
	·		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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